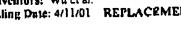
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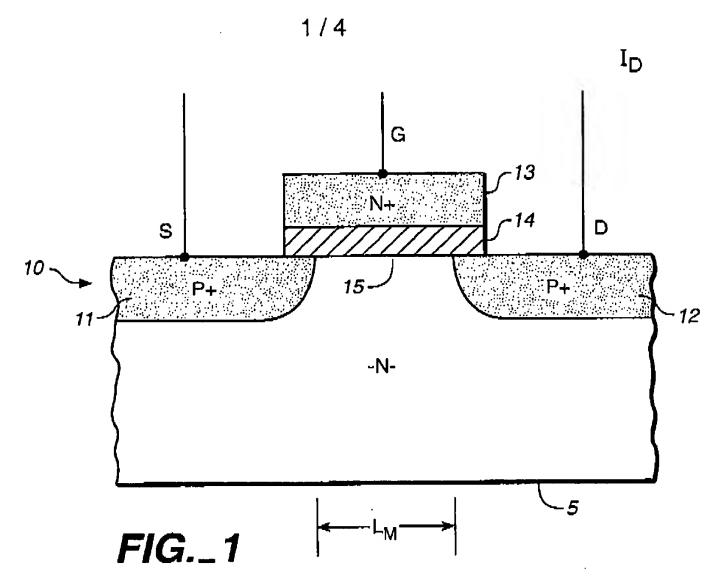
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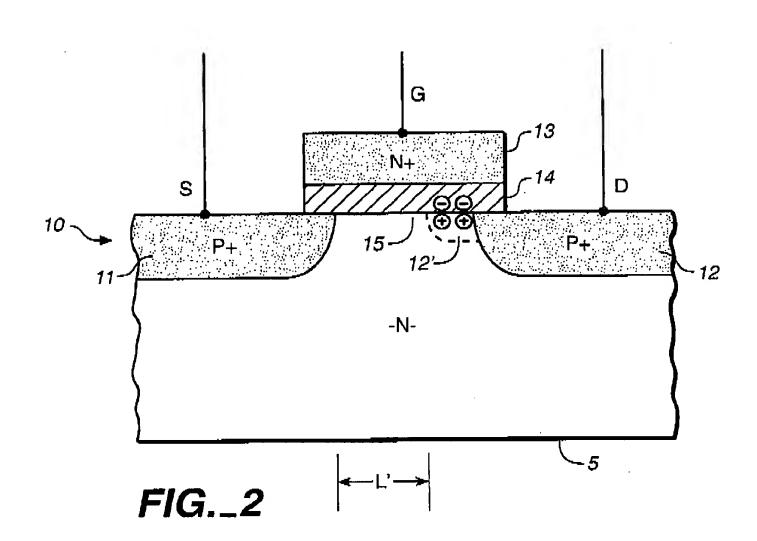
From-DWT SF

Apple. No.: 09/832,933 Docket No.: BTAT.002US1 Title: Hot Carrier Circuit Reliability Simulation

Inventors: Wu et al. Filing Date: 4/11/01 REPLACEMENT SHEET 1 of 4







Appln. No.: 09/832,933 Docket No.: BTAT.002US1 Title: Hot Carrier Circuit Reliability Simulation Inventors: Wu ct al.
Filing Date: 4/11/01 REPLACEMENT SHEET 2 of 4

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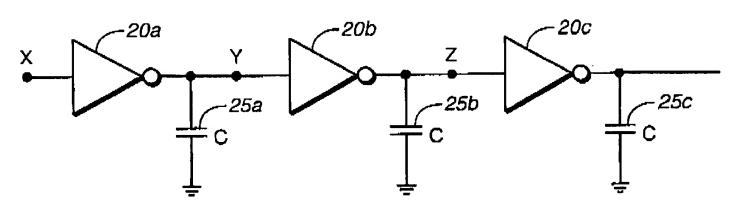
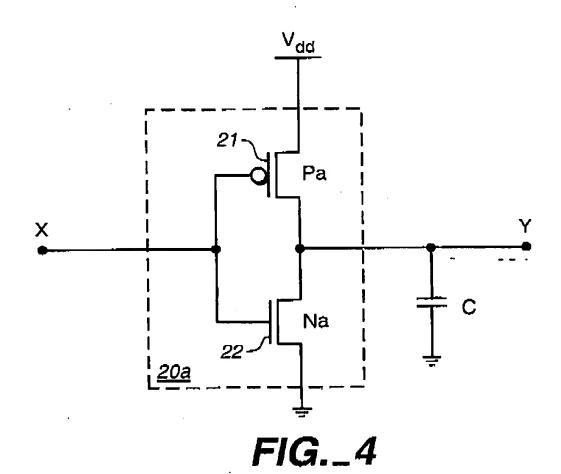


FIG._3

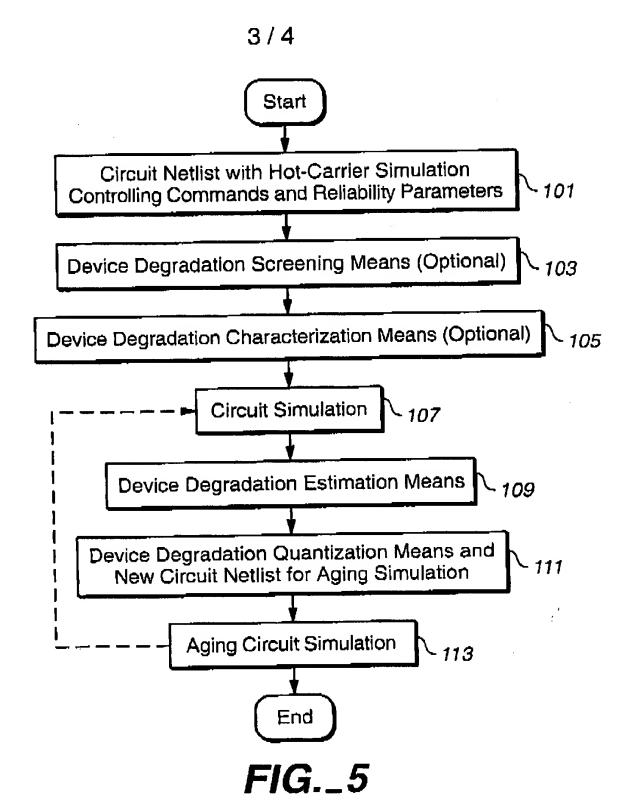


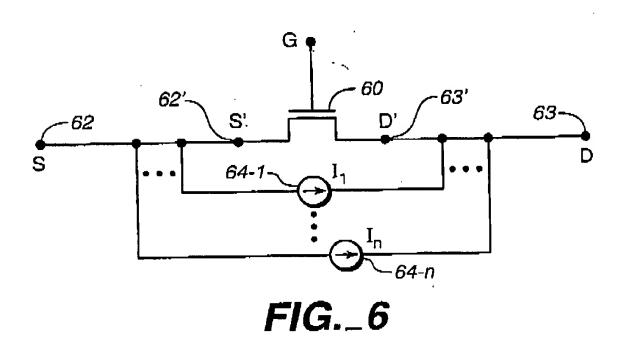
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Apple. No.: 09/832,933 Docket No.: BTAT.002US1 Title: Hot Carrier Circuit Reliability Simulation

Inventors: Wu et al.

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Inventors: Wu et al.
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